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A Tunable Transconductor for Analog Amplification and Filtering based on Double-gate Organic TFTs

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Abstract—This paper presents a transconductor designed using a physical model of double-gate p-type organic thin film transistors (OTFTs). A control voltage can be used to vary the output resistance and the transconductance over one order of magnitude. The voltage gain does not depend on process parameters and therefore is insensitive to shelf and operational degradation. This circuit can be used as a tunable resistor, in voltage amplifiers or in $G_m C$ filters.

I. INTRODUCTION

The interest in electronics manufactured with organic semiconductors (i.e. “organic electronics”) has been constantly growing in the last twenty years. This technology has made a lot of progress both from the performance and the reliability point of view, enabling the design of increasingly more complex organic circuits. Digital circuits, like RFID transponders [1] and microprocessors [2] have been demonstrated. Recently the first comparators, digital-to-analog [3], [4] and analog-to-digital converters [5], [6] have been shown, but more effort must be spent on analog circuit design. Indeed different kinds of organic sensors have already been reported [7] and the lack of a proper frontend and analog signal conditioning is the last hurdle for the realization of fully-integrated smart sensors with organic technologies.

In this paper is presented the design of a linear transconductor suitable for the implementation of voltage amplifiers and $G_m C$ active filters. A novel physical model is used to describe the organic thin-film transistor (OTFT) behavior.

II. DUAL GATE ORGANIC TFTS AND THEIR MODEL

The organic transistors used in this paper are p-type pentacene TFTs with bottom gate structure fabricated using a commercial technology [8] and a new physical model of the OTFT was adopted for this design.

The current conduction in organic TFTs is typically modelled using the concept of variable range hopping (VRH) [9]. According to this theory, in organic semiconductors free carriers jump between localized energy states, therefore the density of states (DOS) defines the electrical properties of the material. In this technology the DOS is well approximated as the sum of two exponential functions [10], [11]: one is valid for the deep states (low energy) and one for the tail states (high energy)¹. In the rest of the paper subscripts “d” and “t” will refer respectively to these two kinds of states.

The channel current I_c can be found combining the deep and tail currents [10], given by

$$I_{d,t} = \beta_{d,t}(V_G - V_S - V_T)^{\gamma_{d,t}} - \beta_{d,t}(V_G - V_D - V_T)^{\gamma_{d,t}}, \quad (1)$$

¹For the sake of simplicity all transistor equations will be written for n-type transistors, even if the technology provides only p-type devices.

according to the equation [11]:

$$I_c = \frac{I_d I_t}{I_d + I_t}. \quad (2)$$

The prefactor β in (1) depends on both geometric and physical parameters of the transistor and the exponent γ , always larger than two, takes into account the superlinear variation of the mobility with the concentration of charge carriers (and thus V_G). The total transistor current can finally be calculated as

$$I_{DS} = I_c \cdot I_s, \quad (3)$$

where the factor I_s takes account of the channel length modulation and reads:

$$I_s = 1 + \left(\frac{V_{DS}}{V_{Early}} \right)^{\frac{1}{\gamma_c+1}}. \quad (4)$$

I_s models the channel modulation due to the space charge limited (SCL) transport in the depletion region [13]. The value of V_{Early} depends on the transistor length, and has been suitably characterized from measurements. In order to keep the continuity of the model the factor I_s multiplies also the linear current, but its effect in the linear region is negligible due to the low V_{DS} .

Given the “shunt combination” of currents in (2), only the smallest among deep and tail current is relevant for the total channel current: hence for hand calculations the smallest among the currents (1) can be considered alone.

The OTFTs used in this work have a second gate controlling the back side of the channel. This “top” gate has the property to influence the transistor threshold, inducing a capacitive division of the bias voltage applied to the bottom gate (V_G) [12]. The effect of the top gate (inset of Fig. 1) on the threshold voltage V_T can be modelled as:

$$V_T = V_{FB} - k(V_{TG} - V_S). \quad (5)$$

In this equation V_{TG} is the voltage applied to the top gate, while the flat band voltage V_{FB} is an intrinsic property of the bottom gate stack, and k is a constant depending on the coupling of the top gate with the channel [8]. It is worth noticing that in our p-type transistors V_T is positive for zero top gate bias, hence the devices are conductive already for $V_{GS} = 0V$. Figure 1 shows the measured and the modelled transfer characteristics of a transistor obtained varying the top gate bias (here it is evident the threshold shifting effect of V_{TG}). Figure 2 plots transfer and output characteristic of a transistor, measured and modelled for $V_{TG} = 0$.

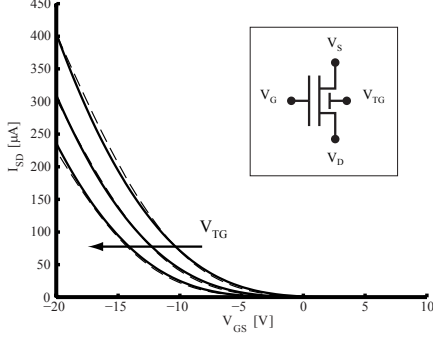


Fig. 1. Transfer characteristic of a pFET for different top gate voltages $V_{TG} = -20V, -10V, 0V$ and $V_{DS} = -10V$. The continuous line represents the measured data, the stippled line the simulated ones.

III. DESIGN OF THE TRANSCONDUCTOR

The design of a transconductor begins with the choice of the actual transconductive element. The technology used, like almost every other organic one, does not provide linear resistors, hence the choice is limited between the linear and saturation regions of the OTFT. In this case linearity was preferred over transconductance, and thus the output resistance of the transistor M_2 (see schematic in Fig. 3) was used to create the transconductance. The transistor M_1 acts as source follower and applies the input voltage on M_2 . The voltage drop on M_2 sets the current that the current mirror (M_3 and M_4) transfer to the output branch. M_5 simply cascodes the output. In case of an ideal source follower and current mirror the transconductance of the circuit would be:

$$G_m = 1/r_{o2} \quad (6)$$

Unfortunately the actual transconductance always happens to be smaller, especially due to few peculiarities of current mirrors in unipolar organic technologies.

A. Current Mirror

Transistors M_3 and M_4 mirror the current from the input branch to the output one. Although really simple, this basic current mirror gains additional interest due to the different physics of the technology underneath. Our transistors have positive threshold voltage, hence the sink device M_3 is always operating in the linear region and M_4 works in saturation only for high source-drain voltages. In our circuit M_5 limits the voltage drop on M_4 which, therefore, is always biased in the ohmic region too. Because of their bias point, it is not possible to obtain together the same transfer function for both the bias and the small-signal currents.

Indeed, being M_3 and M_4 in ohmic region, their current is strongly dependent on V_{DS} , and this voltage changes in a different way for the two devices. If we apply (1) to the current mirror, it can be shown that the small signal current gain $T = \frac{g_{m,d4}}{g_{m,d3}}$ is always smaller than one. The transconductances $g_{m,d4}$ and $g_{m,d3}$ can be written respectively as:

$$\begin{aligned} g_{m,d4} &= \beta_d \gamma_d \left[(V_{GS} - V_{FB})^{\gamma_d - 1} - (V_{GD} - V_{FB})^{\gamma_d - 1} \right] \\ g_{m,d3} &= \beta_d \gamma_d (V_{GS} - V_{FB})^{\gamma_d - 1}, \end{aligned} \quad (7)$$

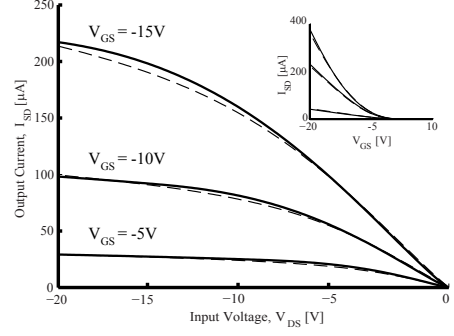


Fig. 2. Output characteristic of a pFET for different gate voltages. The inset shows the transfer characteristic for $V_{DS} = -20V, -10V, -2V$. The continuous line represents the measured data, the stippled line the simulated ones.

and T can be calculated to be:

$$T = 1 - \left(\frac{V_G - V_D - V_{FB}}{V_G - V_S - V_{FB}} \right)^{\gamma_d - 1}, \quad (8)$$

where V_G and V_S are the DC gate and source voltage of both M_3 and M_4 , while V_D is the DC drain voltage of M_4 . T is less than 1 even when $V_D = V_G$ and the bias currents are identical. This is possible because a small variation of V_{GS3} corresponds to a change in V_{DS3} and they both contribute to the variation of I_{SD3} . In the case of M_4 , V_{DS4} does not need to change with V_{GS4} , thus the derivative of I_{SD4} is in general different from the one of I_{SD3} .

B. Transconductive Device and Source Follower

The dimensions of M_2 play the most important role in the final transconductance, but an unsuitable choice of M_1 and M_3 can also negatively affect the performance of the final circuit. This happens when the variations of the voltage on M_3 and of the control voltage of M_1 are not negligible. Too small devices M_1 and M_3 will cause V_{GS1} and V_{GS3} to be large, decreasing the linearity and drastically reducing the input range. On the other hand, too wide M_3 would result in a waste of area, while a wide M_1 would cause a decrease of the input range. Indeed, for low inputs, the source of M_1 would saturate to ground due to the positive threshold voltage. Hence the linear part of the characteristic would not start for $V_{in} = 0V$, but for $V_{in} > V_{GS1}(I_{MAX})$. According to these considerations the final design adopts the same dimensions for all the devices of the input branch.

A slightly higher transconductance of the source follower is advantageous in the transconductor, therefore the top gate of M_1 is also driven by the input voltage. It is easily derived combining (1) and (5) that in this configuration the transconductance of the input device increases by a factor $(1 + k)$.

As explained in the subsection IIIA, the devices M_3 and M_4 operate in their linear region. For this reason the output resistance is really low and the output branch needs to be cascoded. This task is carried out by M_5 . It is worth noticing that the presence of M_5 does not increase the output resistance up to around $g_m r_0^2$, because the source degeneration is weak and the resulting gain of the local negative feedback is low. For this reason the output resistance of the transconductor is, at first order, equal to the output resistance of M_5 . This consideration

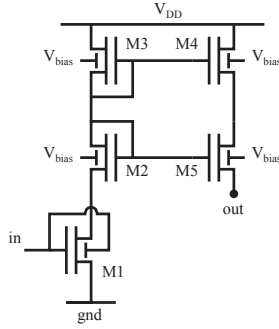


Fig. 3. Schematic for the proposed transconductor.

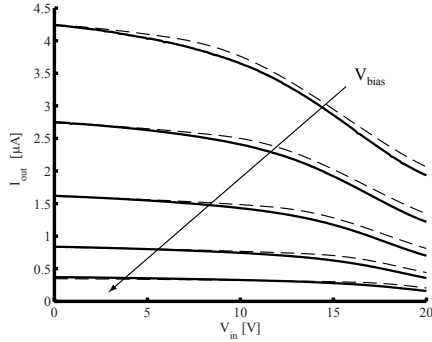


Fig. 4. Output current as a function of the input voltage for different values of $V_{bias} = 0V, 5V, 10V, 15V$ ($V_{out} = 5V$). The continuous line represents the measured data, the stippled line the simulated ones.

let us immediately infer the small signal voltage gain of the circuit (when the output is loaded with a current source - a condition that will be referred to as “unloaded”). Both the transconductance and the output resistance are determined by the r_0 of the two OTFTs M_2 and M_5 , hence the unloaded voltage gain reads:

$$G = T \left(\frac{r_{05}}{r_{02}} \right). \quad (9)$$

C. Output Resistance and Gain

In order to increase the voltage gain, it is possible to change the dimensions of M_5 to decrease the channel length modulation. Table I summarizes the results of different simulations where the W and L of M_5 have been scaled up by the same factor S . The values of V_{Early} for different channel lengths have been measured. As expected the output resistance R_{out} rises and so does the gain G . This scaling however does not

TABLE I
EFFECT OF THE CASCODE CHANNEL LENGTH ON THE GAIN

S	W[μm]	L[μm]	G_m [nA/V]	R_{out} [M Ω]	G
1	1k	5	4.55	228	1.03
2	2k	10	4.51	491	2.21
4	4k	20	3.8	927	3.52
8	8k	40	2.9	1800	5.22

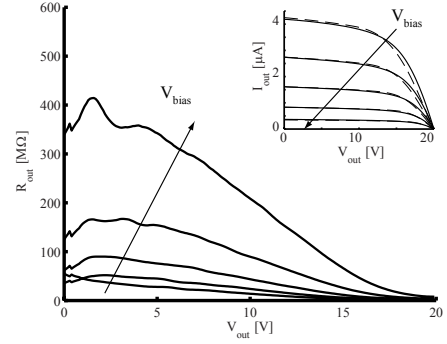


Fig. 5. Measured output resistance for different values of $V_{bias} = 0V, 5V, 10V, 15V, 20V$ ($V_{in} = 5V$). In the inset are shown the measured (continuous line) and simulated (stippled line) output current.

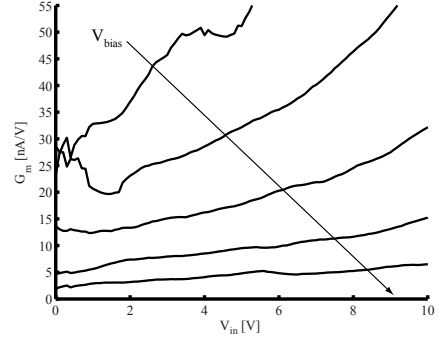


Fig. 6. Measured transconductance as a function of the input voltage for different values of $V_{bias} = 0V, 5V, 10V, 15V$ ($V_{out} = 5V$).

produce a proportional increase in the gain, in fact the output resistance of M_5 affects the bias point of M_4 and causes a drop of T and consequently of G_m .

IV. MEASURED AND SIMULATED RESULTS

The transconductor was realized in the PolymerVision technology and both the transconductance and the output resistance of the transconductor have been evaluated. The circuit was operated at $V_{DD} = 20V$ and different measurements have been taken for different values of the control voltage V_{bias} with a step for the independent variable of $100mV$.

The output resistance is shown in Fig. 5 as a function of the output voltage. This plot was derived from the output current measured applying a constant voltage $V_{in} = 5V$ and sweeping V_{out} from ground to V_{DD} . The measured and simulated output currents are shown in the inset. While increasing the control voltage V_{bias} the output current drops and the resistance rises. The maximum output current goes from $4.098\mu A$ for $V_{bias} = 0V$ to $337.3nA$ for $V_{bias} = 20V$.

The transconductance was derived from the output current (Fig. 4) obtained sweeping the input voltage from ground to V_{DD} . For this measure the output was biased with a voltage source at $V_{out} = 5V$. The resulting transconductance as a function of the input voltage V_{in} is shown in Fig. 6. The current and the transconductance decrease with V_{bias} . Varying the control voltage from ground to V_{DD} , G_m goes from $18.67nA/V$ to $2.16nA/V$. From Fig. 6 the influence of V_{bias} on the linearity of the circuit can also be evaluated. The higher

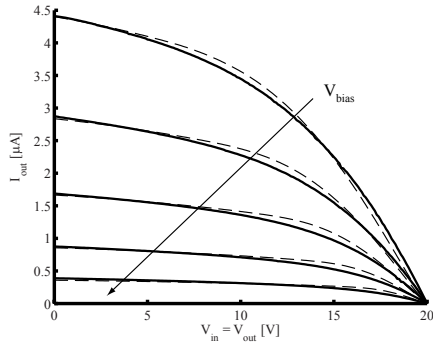


Fig. 7. Current flowing out of the transconductor, with V_{in} connected to V_{out} , as a function of the input voltage for different values of $V_{bias} = 0V, 5V, 10V, 15V$. The continuous line represents the measured data, the stippled line the simulated ones.

the control voltage, the larger is the linear input range or, with the same input range, a higher linearity is achieved.

The sets of data in Fig. 4, 5 and 6 (summarized in Table II for $V_{in} = 5V$ and $V_{out} = 5V$) also confirm what stated the section III C. The unloaded gain of the circuit is indeed almost independent on the bias voltage (and on V_T), while it depends on the difference between the output resistance of the devices M_2 and M_5 . The two devices have here same W/L ratio and channel length, hence the gain is about one. The actual gain value is slightly higher than 1 because the output resistance of the mirror, i.e. of M_4 , increases the output resistance of the transconductor compared to the R_{out} of M_5 . This effect more than compensates the reduction in transconductance G_m due to the actual transfer factor T and to the source follower.

Connecting together input and output nodes, a tunable resistor connected to V_{DD} is obtained. The measured current of such configuration is shown in Fig. 7 for different values of the control voltage V_{bias} .

The last figure (Fig. 8) shows the simulated Bode magnitude plot of the transconductor in a $G_m C$ filter configuration (see the schematic in the inset). The capacitance of the filter has a value of $C = 100pF$ and the load M_6 is $0V_{gs}$ connected to embody a current source. The loss of gain due to the finite output resistance of M_6 is not present when M_6 is substituted with an ideal current source. Future work will focus on the realization of a feedback system to match the DC currents of transconductor and load. In this way it would be possible to move the cut-off frequency changing V_{bias} , and thus G_m , without influencing the gain.

TABLE II
MEASUREMENT SUMMARY

V_{bias} [V]	R_{out} [MΩ]	G_m [nA/V]	G
0	27	51	1.37
5	44	32	1.4
10	76	18	1.36
15	153	9.5	1.45
20	342	4.7	1.6

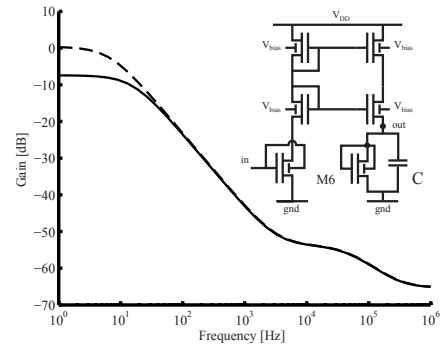


Fig. 8. Bode magnitude plot of the circuit in the inset (continuous line). The stippled line represents the transfer function using an ideal current source in place of M_6 .

V. CONCLUSION

Adopting a physical model of OTFTs a transconductor suitable for analog signal conditioning was designed in a unipolar double gate technology. Simulations approximate well the measurement and demonstrate what analytically derived. The unloaded voltage gain mainly depends on a channel length ratio and is weakly sensitive to most process parameters, e.g. the threshold voltage, and hence to their time variation due to ageing.

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